Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attomey's Docket No. 12732-217001	Application No. New Application	
Information Disclosure Statement by Applicant		Applicant Shunpei Yamazaki et al.		
(Use several si	heets if necessary)	Filing Date March 15, 2004	Group Art Unit	

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EXAMINER: Initials citation considered. Draw line through citation if no next communication to applicant.	ot in conformance and not considered. Include copy of this form with

(Modified)	U.S. Department of Commerce Patent and Trademark Office	Attomey's Docket No. 12732-217001	Application No. 10/799,756	
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		Filing Date March 15, 2004	Group Art Unit 2673	

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Substitute Form PTO-1449	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-217001	Application No. 10/799,756	
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Application No. 10/799,756

Information Disclosure Statement

by Applicant (Use several sheets if necessary)

Applicant Shunpei Yamazaki et al.

Filing Date
March 15, 2004

Group Art Unit 2673

(37 CFR §1.98(b))

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